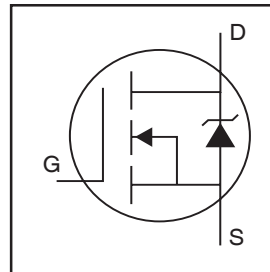


# IRFL024ZPbF

HEXFET® Power MOSFET

## Features

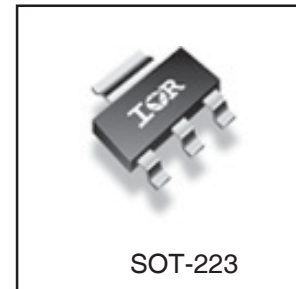
- Advanced Process Technology
- Ultra Low On-Resistance
- 150°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to  $T_{jmax}$
- Lead-Free



|                            |
|----------------------------|
| $V_{DSS} = 55V$            |
| $R_{DS(on)} = 57.5m\Omega$ |
| $I_D = 5.1A$               |

## Description

This HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 150°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in a wide variety of applications.



## Absolute Maximum Ratings

|                              | Parameter  | Max.                     | Units |
|------------------------------|--|--------------------------|-------|
| $I_D @ T_A = 25^\circ C$     | Continuous Drain Current, $V_{GS} @ 10V$ (Silicon Limited) ⑦ | 5.1                      | A     |
| $I_D @ T_A = 70^\circ C$     | Continuous Drain Current, $V_{GS} @ 10V$ ⑦                   | 4.1                      |       |
| $I_{DM}$                     | Pulsed Drain Current ①                                       | 41                       |       |
| $P_D @ T_A = 25^\circ C$     | Power Dissipation ⑦  | 2.8                      |       |
| $P_D @ T_A = 25^\circ C$     | Power Dissipation ⑧  | 1.0                      | W     |
|                              | Linear Derating Factor ⑦                                     | 0.02                     | W/°C  |
| $V_{GS}$                     | Gate-to-Source Voltage                                       | $\pm 20$                 | V     |
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy ②                              | 13                       | mJ    |
| $E_{AS}$ (Tested )           | Single Pulse Avalanche Energy Tested Value ②                 | 32                       |       |
| $I_{AR}$                     | Avalanche Current ①  | See Fig.12a, 12b, 15, 16 | A     |
| $E_{AR}$                     | Repetitive Avalanche Energy ⑤                                |                          | mJ    |
| $T_J$                        | Operating Junction and                                       | -55 to + 150             | °C    |
| $T_{STG}$                    | Storage Temperature Range                                    |                          |       |

## Thermal Resistance

|                 | Parameter                                       | Typ. | Max. | Units |
|-----------------|---|------|------|-------|
| $R_{\theta JA}$ | Junction-to-Ambient (PCB mount, steady state) ⑦ | —    | 45   | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB mount, steady state) ⑧ | —    | 120  |       |

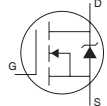
# IRFL024ZPbF

International  
IR Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

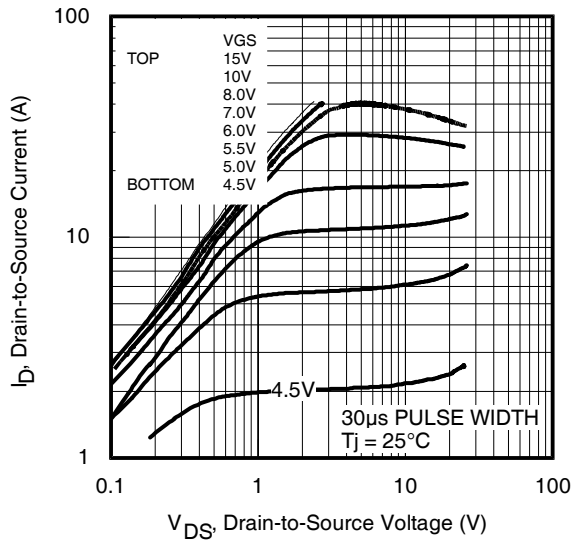
|                                 | Parameter                            | Min. | Typ.  | Max. | Units               | Conditions   |
|---------------------------------|--------------------------------------|------|-------|------|---------------------|--|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 55   | —     | —    | V                   | $V_{GS} = 0V, I_D = 250\mu A$                        |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.053 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D = 1\text{mA}$    |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 46.2  | 57.5 | m $\Omega$          | $V_{GS} = 10V, I_D = 3.1A$ ③                         |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —     | 4.0  | V                   | $V_{DS} = V_{GS}, I_D = 250\mu A$                    |
| gfs                             | Forward Transconductance             | 6.2  | —     | —    | S                   | $V_{DS} = 25V, I_D = 3.1A$                           |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —     | 20   | $\mu A$             | $V_{DS} = 55V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —     | 250  |                     | $V_{DS} = 55V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —     | 200  | nA                  | $V_{GS} = 20V$                                       |
|                                 | Gate-to-Source Reverse Leakage       | —    | —     | -200 |                     | $V_{GS} = -20V$                                      |
| $Q_g$                           | Total Gate Charge                    | —    | 9.1   | 14   | nC                  | $I_D = 3.1A$   |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | 1.9   | —    |                     | $V_{DS} = 44V$                                       |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | 3.9   | —    |                     | $V_{GS} = 10V$ ③                                     |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 7.8   | —    | ns                  | $V_{DD} = 28V$                                       |
| $t_r$                           | Rise Time                            | —    | 21    | —    |                     | $I_D = 3.1A$   |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 30    | —    |                     | $R_G = 53\ \Omega$                                   |
| $t_f$                           | Fall Time                            | —    | 23    | —    |                     | $V_{GS} = 10V$ ③                                     |
| $C_{iss}$                       | Input Capacitance                    | —    | 340   | —    | pF                  | $V_{GS} = 0V$  |
| $C_{oss}$                       | Output Capacitance                   | —    | 68    | —    |                     | $V_{DS} = 25V$                                       |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 39    | —    |                     | $f = 1.0\text{MHz}$                                  |
| $C_{oss}$                       | Output Capacitance                   | —    | 210   | —    |                     | $V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0\text{MHz}$      |
| $C_{oss}$                       | Output Capacitance                   | —    | 55    | —    |                     | $V_{GS} = 0V, V_{DS} = 44V, f = 1.0\text{MHz}$       |
| $C_{oss\ eff.}$                 | Effective Output Capacitance         | —    | 93    | —    |                     | $V_{GS} = 0V, V_{DS} = 0V\ \text{to}\ 44V$ ④         |

## Source-Drain Ratings and Characteristics

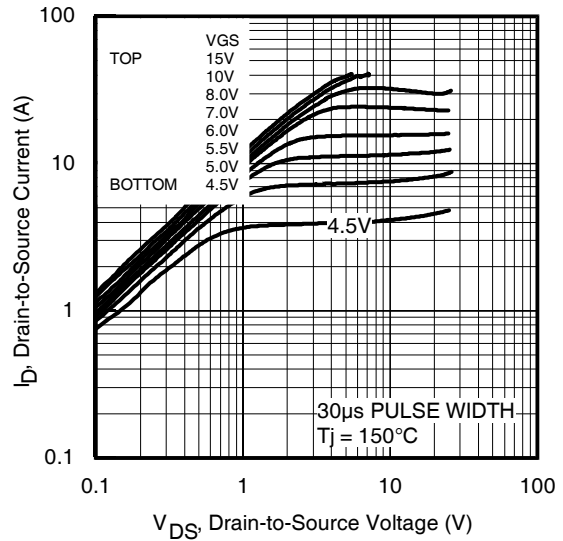
|          | Parameter                                 | Min.   | Typ. | Max. | Units | Conditions   |
|----------|---|--|------|------|-------|--|
| $I_S$    | Continuous Source Current<br>(Body Diode) | —  | —    | 5.1  | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$ | Pulsed Source Current<br>(Body Diode) ①   | —  | —    | 41   |       |  |
| $V_{SD}$ | Diode Forward Voltage                     | —  | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 3.1A, V_{GS} = 0V$ ②  |
| $t_{rr}$ | Reverse Recovery Time                     | —  | 15   | 23   | ns    | $T_J = 25^\circ\text{C}, I_F = 3.1A, V_{DD} = 28V$   |
| $Q_{rr}$ | Reverse Recovery Charge                   | —  | 9.8  | 15   | nC    | $di/dt = 100A/\mu s$ ③   |
| $t_{on}$ | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) |      |      |       |  |

### Notes:

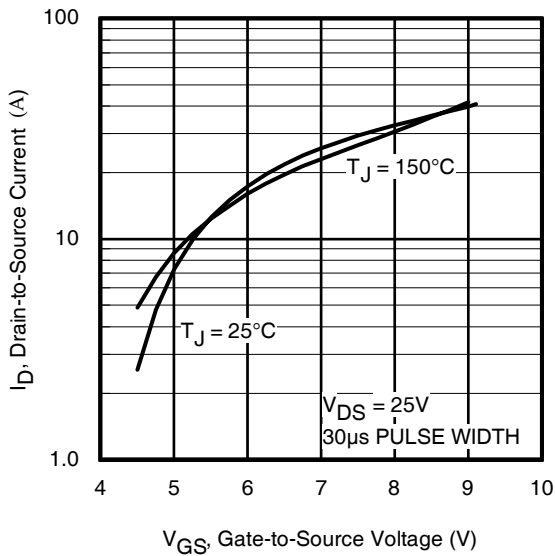
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 2.8\text{mH}$   
 $R_G = 25\ \Omega, I_{AS} = 3.1A, V_{GS} = 10V$ .  
Part not recommended for use above this value.
- ③ Pulse width  $\leq 1.0\text{ms}$ ; duty cycle  $\leq 2\%$ .
- ④  $C_{oss\ eff.}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑤ Limited by  $T_{Jmax}$ , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑥ This value determined from sample failure population. 100% tested to this value in production.
- ⑦ When mounted on 1 inch square copper board.
- ⑧ When mounted on FR-4 board using minimum recommended footprint.



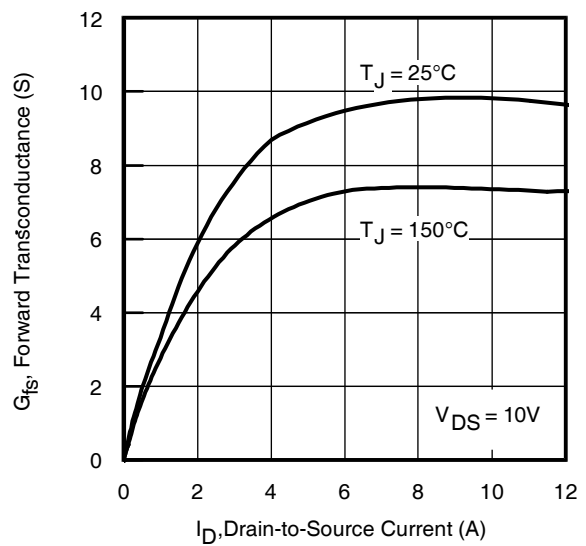
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics

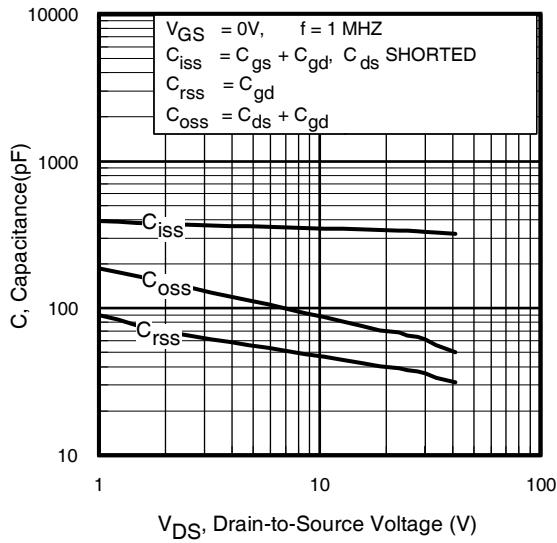


**Fig 3.** Typical Transfer Characteristics

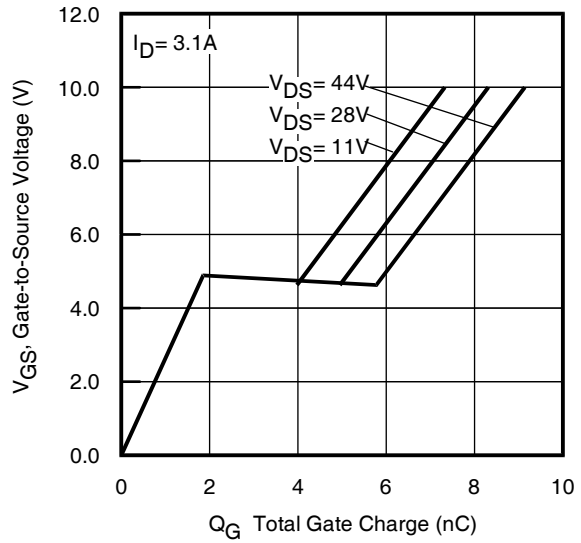


**Fig 4.** Typical Forward Transconductance vs. Drain Current

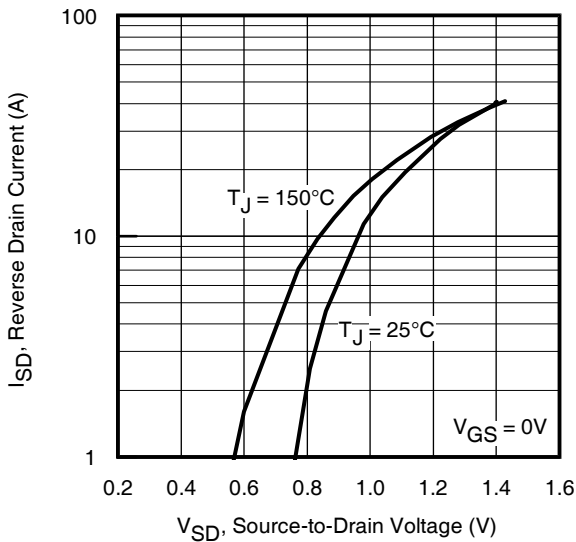
# IRFL024ZPbF



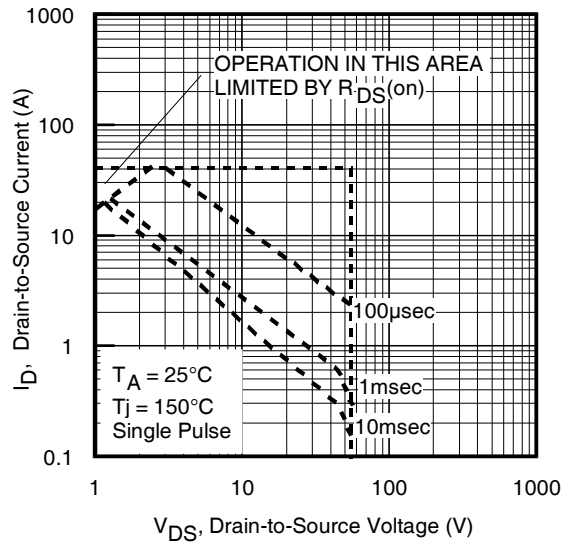
**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



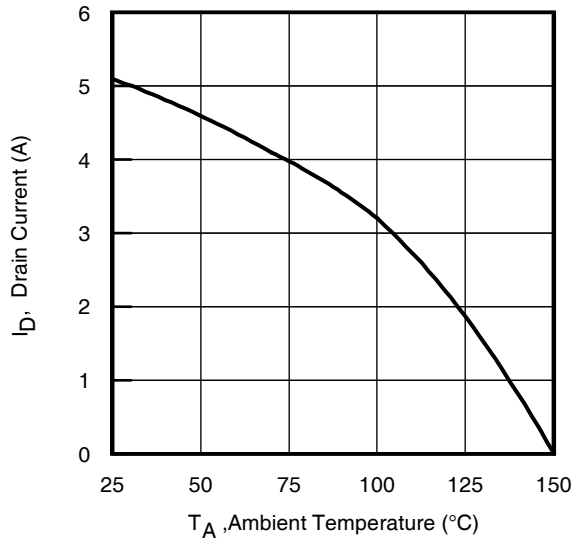
**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage



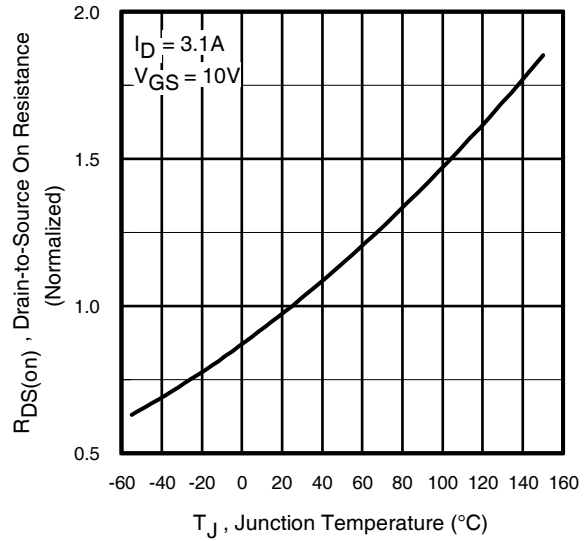
**Fig 7.** Typical Source-Drain Diode Forward Voltage



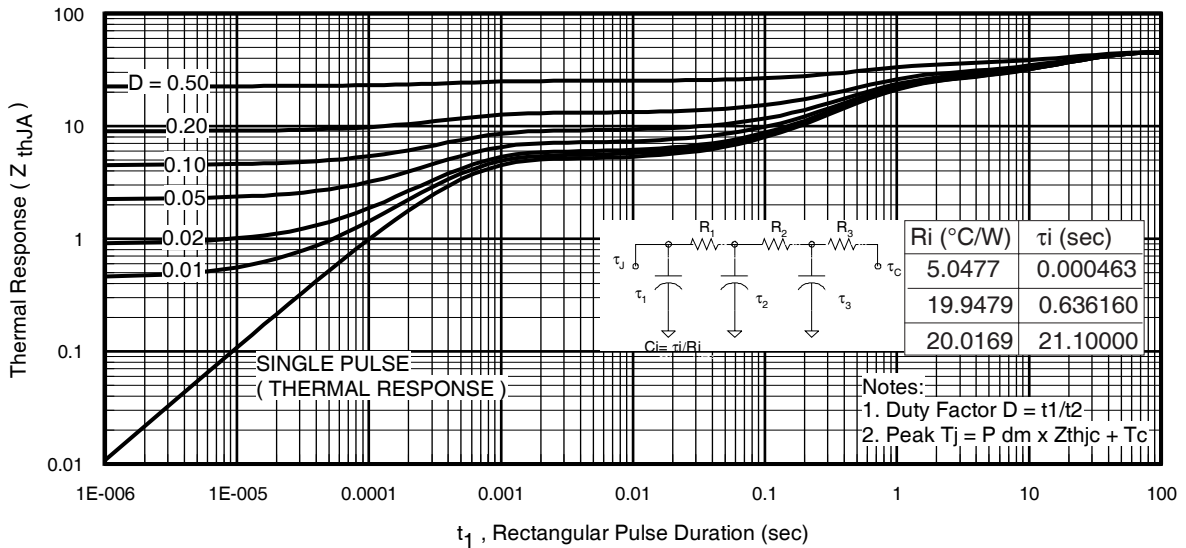
**Fig 8.** Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current vs. Ambient Temperature



**Fig 10.** Normalized On-Resistance vs. Temperature



**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

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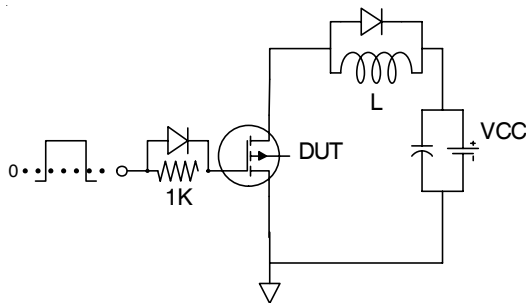
**Fig 12a.** Unclamped Inductive Test Circuit



**Fig 12b.** Unclamped Inductive Waveforms

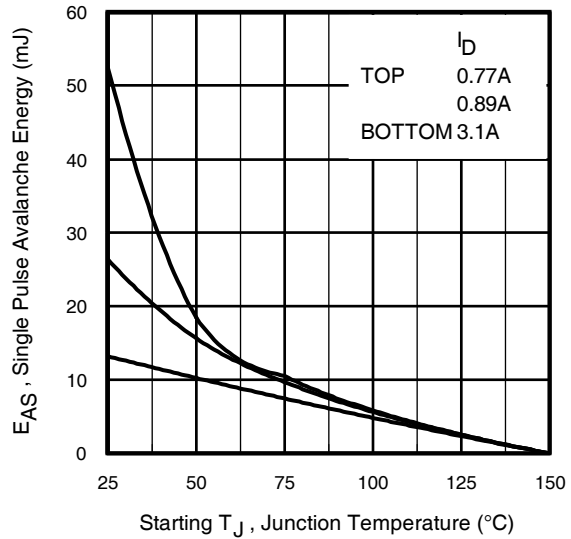


**Fig 13a.** Basic Gate Charge Waveform

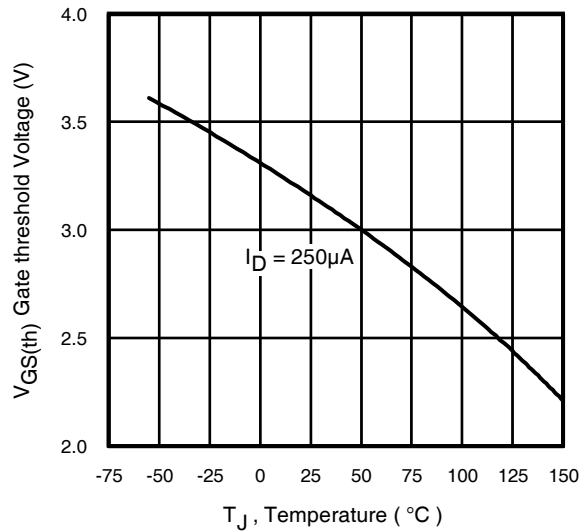


**Fig 13b.** Gate Charge Test Circuit

6



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current



**Fig 14.** Threshold Voltage vs. Temperature

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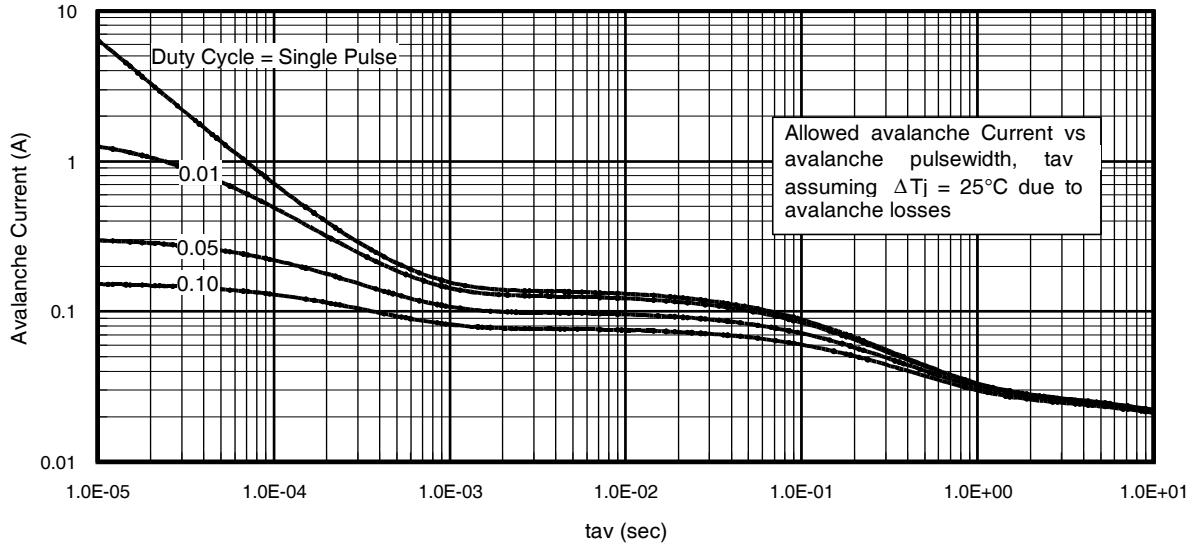


Fig 15. Typical Avalanche Current vs.Pulsewidth

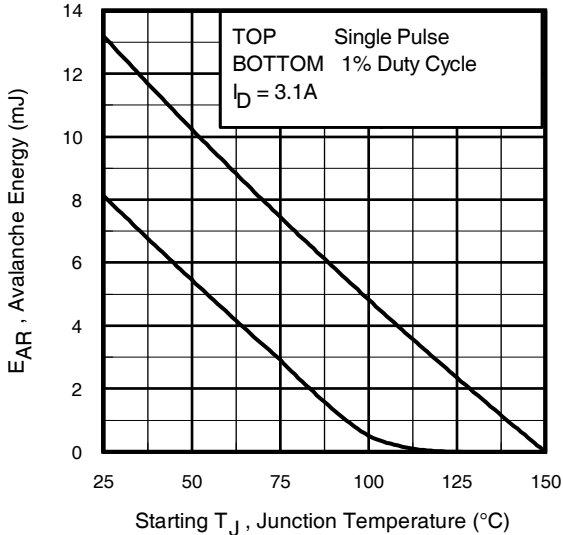


Fig 16. Maximum Avalanche Energy vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 15, 16:**  
**(For further info, see AN-1005 at www.irf.com)**

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5.  $BV$  = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 15, 16).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$



**Fig 17. Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs**



**Fig 18a. Switching Time Test Circuit**

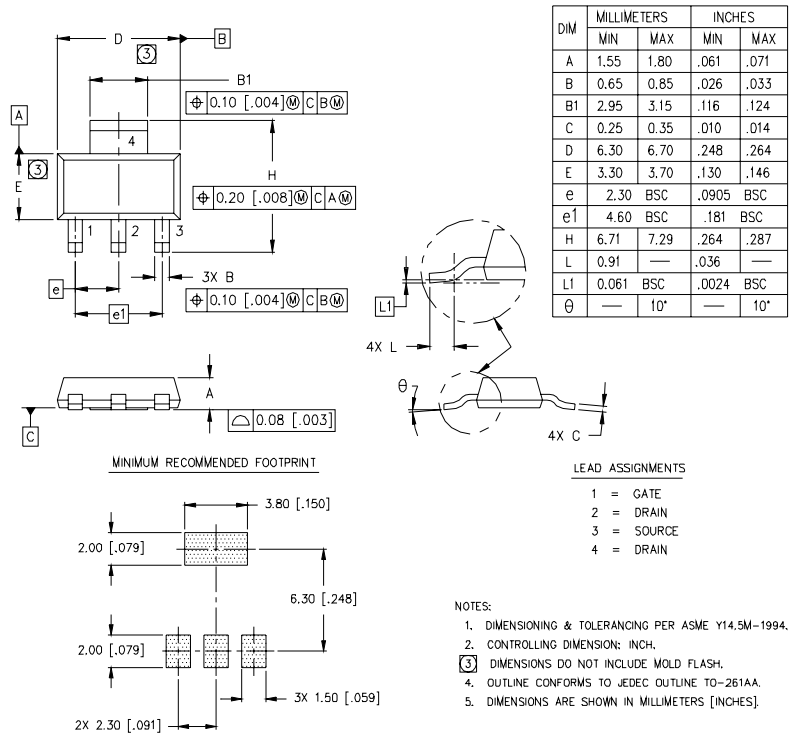


**Fig 18b. Switching Time Waveforms**



## SOT-223 (TO-261AA) Package Outline

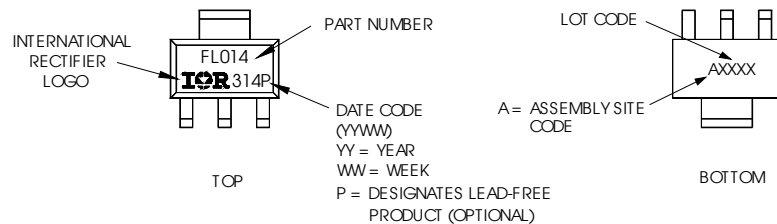
Dimensions are shown in millimeters (inches)



## SOT-223 (TO-261AA) Part Marking Information

### HEXFET PRODUCT MARKING

EXAMPLE: THIS IS AN IRFL014



### Notes:

1. For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/aut/>
2. For the most current drawing please refer to IR website at <http://www.irf.com/package/>

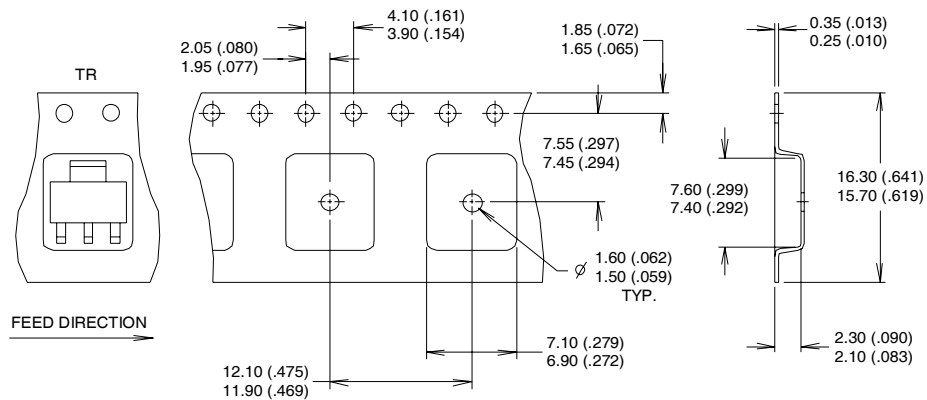
[www.irf.com](http://www.irf.com)

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**IR** Rectifier

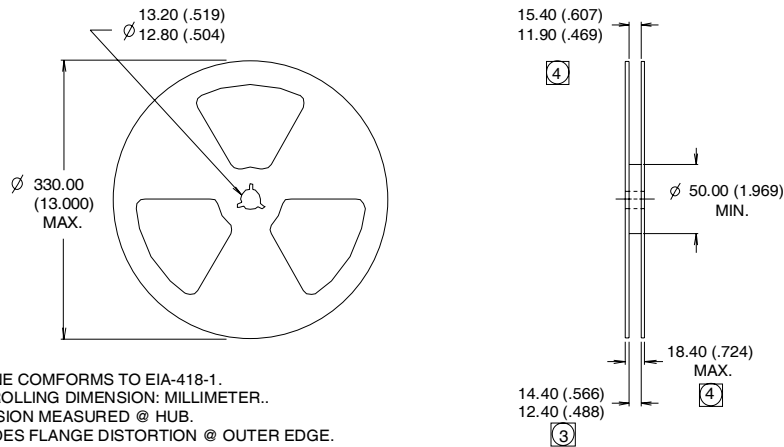
## SOT-223 (TO-261AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



### NOTES :

1. CONTROLLING DIMENSION: MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.
3. EACH  $\varnothing 330.00$  (13.00) REEL CONTAINS 2,500 DEVICES.



### NOTES :

1. OUTLINE COMFORMS TO EIA-418-1.
2. CONTROLLING DIMENSION: MILLIMETER..
- ③ DIMENSION MEASURED @ HUB.
- ④ INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Data and specifications subject to change without notice.  
This product has been designed for the Industrial market.  
Qualification Standards can be found on IR's Web site.

International  
**IR** Rectifier

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